

EMC TEST REPORT
for
iLike Electronics Co., Ltd.

HEADPHONE

Model No.: DJ-8805, N-DJ8805, DJ-6601, DJ-9700, DJ-9701, DJ-8803, DJ-8802, DJ-8802-2, DJ-8800-2, DJ-9903, DJ-8811, DJ-1005, DJ-9700B, DJ-9900, DJ-1000, DJ-2000, DJ-9000, DJ-9100, DJ-9200, DJ-9400, DJ-9010, DJ-9800, DJ-9500, DJ-8700, DJ-885, DJ-980B, DJ-980, DJ-981, DJ-981B, DJ-8600, DJ-8601, DJ-8100, DJ-840, DJ-840B

Prepared for : iLike Electronics Co., Ltd.
Address : Industrial Areas of AILIJ, JULING OLD VILLAGE,
DASHUIKENG, GUANLAN, LONGHUA NEW AREA,
SHENZHEN, CHINA.

Prepared By : Accurate Technology Co., Ltd.
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Report Number : ATE20140982
Date of Test : June 12, 2014
Date of Report : June 13, 2014

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TEST REPORT

Applicant : iLike Electronics Co., Ltd.
Manufacturer : iLike Electronics Co., Ltd.
Product : HEADPHONE
Model No. : DJ-8805, N-DJ8805, DJ-6601, DJ-9700, DJ-9701, DJ-8803,
DJ-8802, DJ-8802-2, DJ-8800-2, DJ-9903, DJ-8811, DJ-1005,
DJ-9700B, DJ-9900, DJ-1000, DJ-2000, DJ-9000, DJ-9100,
DJ-9200, DJ-9400, DJ-9010, DJ-9800, DJ-9500, DJ-8700,
DJ-885, DJ-980B, DJ-980, DJ-981, DJ-981B, DJ-8600,
DJ-8601, DJ-8100, DJ-840, DJ-840B

Measurement Procedure Used:

EN 55022: 2010

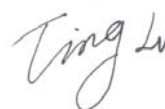
**EN 55024: 2010 (IEC 61000-4-2: 2008
IEC 61000-4-3: 2010
IEC 61000-4-8: 2009)**

The device described above is tested by Accurate Technology Co., Ltd. to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Accurate Technology Co., Ltd. is assumed full of responsibility for the accuracy and completeness of these measurements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Accurate Technology Co., Ltd.

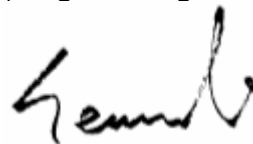
Date of Test :

June 12, 2014



Prepared by :

(Ting Lü, Engineer)



Approved & Authorized Signer :

(Sean Liu, Manager)

1. TEST RESULTS SUMMARY

Test Items	Test Standard	Test Results
Radiated Emission	EN 55022: 2010	Pass
Electrostatic Discharge Immunity	EN 55024: 2010 (IEC 61000-4-2: 2008)	Pass
Radiated Electromagnetic Fields Immunity	EN 55024: 2010 (IEC 61000-4-3: 2010)	Pass
Magnetic Field Immunity	EN 55024: 2010 (IEC 61000-4-8: 2009)	Pass

2. GENERAL INFORMATION

2.1. Description of Device (EUT)

Product : HEADPHONE

Model No. : DJ-8805, N-DJ8805, DJ-6601, DJ-9700, DJ-9701, DJ-8803, DJ-8802, DJ-8802-2, DJ-8800-2, DJ-9903, DJ-8811, DJ-1005, DJ-9700B, DJ-9900, DJ-1000, DJ-2000, DJ-9000, DJ-9100, DJ-9200, DJ-9400, DJ-9010, DJ-9800, DJ-9500, DJ-8700, DJ-885, DJ-980B, DJ-980, DJ-981, DJ-981B, DJ-8600, DJ-8601, DJ-8100, DJ-840, DJ-840B

(Note: Different wattage, color of body, color temperature of light. So we prepare DJ-8805 for test only.)

Rating : Powered by iPod

Applicant : iLike Electronics Co., Ltd.

Address : Industrial Areas of AILIJ, JULING OLD VILLAGE, DASHUIKENG, GUANLAN, LONGHUA NEW AREA, SHENZHEN, CHINA.

Manufacturer : iLike Electronics Co., Ltd.

Address : Industrial Areas of AILIJ, JULING OLD VILLAGE, DASHUIKENG, GUANLAN, LONGHUA NEW AREA, SHENZHEN, CHINA.

Date of sample received : June 10, 2014

Date of Test : June 12, 2014

2.2. Accessory and Auxiliary Equipment

iPod : Manufacturer: Apple
Model: A1238
Serial No.: 8K039T1Y9ZU

2.3. Description of Test Facility

- EMC Lab : Accredited by TUV Rheinland Shenzhen, May 10, 2004
- Listed by FCC
The Registration Number is 253065
Listed by FCC
The Registration Number is 752051
- Listed by Industry Canada
The Registration Number is 5077A-1
Listed by Industry Canada
The Registration Number is 5077A-2
- Accredited by China National Accreditation Committee for Laboratories
The Certificate Registration Number is L3193
- Name of Firm : Accurate Technology Co., Ltd.
Site Location : F1, Bldg. A&D, Changyuan New Material Port, Keyuan Rd., Science & Industry Park, Nanshan District, Shenzhen 518057, P.R. China
- Subcontracted Items : RF Field Strength Susceptibility Test
- Subcontractor : Shenzhen Academy of Metrology and Quality Inspection
Site Location : Bldg. of Shenzhen Academy of Metrology and Quality Inspection, Longzhu Road, Nanshan, Shenzhen, China.

2.4. Measurement Uncertainty

- Radiated emission expanded uncertainty (9kHz-30MHz) : U=3.08dB, k=2
- Radiated emission expanded uncertainty (30MHz-1000MHz) : U=4.42dB, k=2
- Radiated emission expanded uncertainty (Above 1GHz) : U=4.06dB, k=2
- Conduction Emission Expanded Uncertainty : U=2.23dB, k=2
- Power disturbance Expanded Uncertainty : U=2.92dB, k=2

3. MEASURING DEVICE AND TEST EQUIPMENT

3.1. For Radiated Emission Measurement

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Spectrum Analyzer	Agilent	E7405A	MY45115511	Jan. 11, 2014	1 Year
2.	Spectrum Analyzer	Rohde&Schwarz	FSV40	101495	Jan. 11, 2014	1 Year
3.	Test Receiver	Rohde&Schwarz	ESCS30	100307	Jan. 11, 2014	1 Year
4.	Test Receiver	Rohde& Schwarz	ESPI3	100396/003	Jan. 11, 2014	1 Year
5.	Test Receiver	Rohde& Schwarz	ESPI3	101526/003	Jan. 11, 2014	1 Year
6.	Bilog Antenna	Schwarzbeck	VULB9163	9163-194	Jan. 15, 2014	1 Year
7.	Bilog Antenna	Schwarzbeck	VULB9163	9163-323	Jan. 15, 2014	1 Year
8.	Log.-Per.Antenna	Schwarzbeck	VUSLP 9111B	9111B-074	Jan. 15, 2014	1 Year
9.	Biconical Broad Band Antenna	Schwarzbeck	VHBB 9124+BBA 9106	9124-617	Jan. 15, 2014	1 Year
10.	Loop Antenna	Schwarzbeck	FMZB1516	1516131	Jan. 15, 2014	1 Year
11.	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-655	Jan. 15, 2014	1 Year
12.	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-1067	Jan. 15, 2014	1 Year
13.	Vertical Active Monopole Antenna	Schwarzbeck	VAMP 9243	9243-370	Jan. 15, 2014	1 Year
14.	RF Switching Unit+PreAMP	Compliance Direction	RSU-M2	38322	Jan. 11, 2014	1 Year
15.	Pre-Amplifier	Agilent	8447D	294A10619	Jan. 11, 2014	1 Year
16.	Pre-Amplifier	Rohde&Schwarz	CBLU11835 40-01	3791	Jan. 11, 2014	1 Year
17.	50 Coaxial Switch	Anritsu Corp	MP59B	6200237248	Jan. 11, 2014	1 Year
18.	50 Coaxial Switch	Anritsu Corp	MP59B	6200506474	Jan. 11, 2014	1 Year
19.	RF Coaxial Cable	Schwarzbeck	N-5m	No.1	Jan. 11, 2014	1 Year
20.	RF Coaxial Cable	Schwarzbeck	N-1m	No.6	Jan. 11, 2014	1 Year
21.	RF Coaxial Cable	Schwarzbeck	N-1m	No.7	Jan. 11, 2014	1 Year
22.	RF Coaxial Cable	SUHNER	N-3m	No.8	Jan. 11, 2014	1 Year
23.	RF Coaxial Cable	RESENBERGER	N-3.5m	No.9	Jan. 11, 2014	1 Year
24.	RF Coaxial Cable	SUHNER	N-6m	No.10	Jan. 11, 2014	1 Year
25.	RF Coaxial Cable	RESENBERGER	N-12m	No.11	Jan. 11, 2014	1 Year
26.	RF Coaxial Cable	RESENBERGER	N-0.5m	No.12	Jan. 11, 2014	1 Year
27.	RF Coaxial Cable	SUHNER	N-2m	No.13	Jan. 11, 2014	1 Year
28.	RF Coaxial Cable	SUHNER	N-0.5m	No.15	Jan. 11, 2014	1 Year
29.	RF Coaxial Cable	SUHNER	N-2m	No.16	Jan. 11, 2014	1 Year
30.	RF Coaxial Cable	RESENBERGER	N-6m	No.17	Jan. 11, 2014	1 Year

3.2.For Electrostatic Discharge Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	ESD Tester	HAEFELY	PESD1610	H4001552	Jan.15, 2014	1 Year

3.3.For RF Strength Susceptibility Test

Item	Equipment	Manufacturer	Model No.	Eqpt No.	Last Cal.	Cal. Interval
1.	Signal Generator	Rohde&Schwarz	SMB100A	SB9422/02	Aug. 21, 2013	1 Year
2.	Signal Generator	Rohde&Schwarz	SMF100A	SB8501/03	May 14, 2013	1 Year
3.	Voltage Meter	Rohde&Schwarz	URV5-Z2	SB9422/03	Aug. 21, 2013	1 Year
4.	Voltage Meter	Rohde&Schwarz	URV5-Z2	SB9422/04	Aug. 21, 2013	1 Year
5.	Power Probe	Rohde&Schwarz	NRP-Z81	SB9422/06	Aug. 21, 2013	1 Year
6.	Power Probe	Rohde&Schwarz	NRP-Z81	SB9422/07	Aug. 21, 2013	1 Year
7.	Power Meter	Rohde&Schwarz	NRP	SB9422/05	Aug. 21, 2013	1 Year
8.	Power Amplifier	PRANA	MT310A	SB9422/08	Aug. 21, 2013	1 Year
9.	Broadband Antenna	Rohde&Schwarz	HL046E	SB9422/13	Aug. 21, 2013	1 Year
10.	Horn Antenna	AR	ATH800M5G A	SB9422/15	Aug. 21, 2013	1 Year
11.	Power Amplifier	MILMEGA	A-001	SB9422/10	Aug. 21, 2013	1 Year
12.	Power Meter	Rohde&Schwarz	NRVD	SB3437	Aug. 21, 2013	1 Year

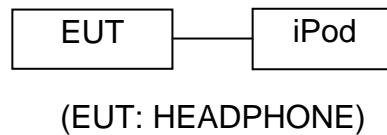
3.4.For Magnetic Field Immunity Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Magnetic Field Tester	HAEFELY	MAG100	150577	Jan.11, 2014	1 Year

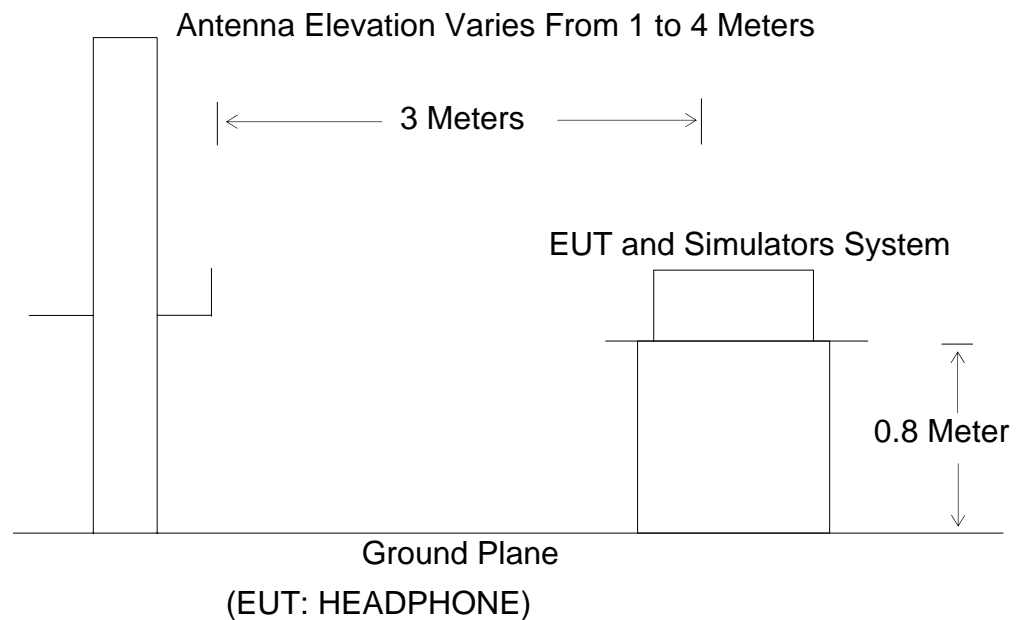
4. RADIATED EMISSION MEASUREMENT

4.1. Block Diagram of Test

4.1.1. Block diagram of connection between the EUT and simulators



4.1.2. Block diagram of test setup (In chamber)



4.2. Measuring Standard

EN 55022: 2010

4.3. Radiated Emission Limits (Class B)

4.3.1. Limit below 1GHz

Frequency (MHz)	Quasi-peak limits dB(μ V/m)
30 – 230	40
230 - 1000	47
Note: (1) The smaller limit shall apply at the combination point between two frequency bands. (2) Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the EUT.	

4.3.2. Limit above 1GHz

Frequency (GHz)	Average Limit dB(μ V/m)	Peak Limit dB(μ V/m)
1 – 3	50	70
3 - 6	54	74
Note: The lower limit applies at the transition frequency.		

4.4. Conditional Testing Procedure

If the highest frequency of the internal sources of the EUT is less than 108MHz, the measurement shall only be made up to 1GHz.

If the highest frequency of the internal sources of the EUT is between 108MHz and 500MHz, the measurement shall only be made up to 2GHz.

If the highest frequency of the internal sources of the EUT is between 500MHz and 1GHz, the measurement shall only be made up to 5GHz.

If the highest frequency of the internal sources of the EUT is above 1GHz, the measurement shall only be made up to 5 times the highest frequency or 6GHz, whichever is less.

4.5. EUT Configuration on Test

The configuration of the EUT is same as Section 4.4.

4.6. Operating Condition of EUT

- 4.6.1. Setup the EUT and simulator as shown as Section 4.1.
- 4.6.2. Turn on the power of all equipment.
- 4.6.3. Let the EUT work in test mode (Playing) and measure it.

4.7. Test Procedure

The EUT is placed on a turntable, which is 0.8 meter high above the ground. The turntable can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna, which is mounted on an antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Bilog antenna (calibrated by Dipole Antenna) is used as a receiving antenna. Both horizontal and vertical polarizations of the antenna are set on test.

The bandwidth of the Receiver (ESCS30) is set at 120 kHz in 30-1000MHz, and 1MHz in above 1000MHz.

4.8.Measuring Results

PASS.

The frequency range from 30MHz to 1000MHz is investigated.

Test Mode: Playing								
Polarization								
Horizontal	No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
	1	52.2659	27.66	-12.76	14.90	40.00	-25.10	QP
	2	159.7586	30.78	-14.57	16.21	40.00	-23.79	QP
	3	713.6915	25.65	-1.56	24.09	47.00	-22.91	QP
Vertical	No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector
	1	40.4411	25.59	-11.64	13.95	40.00	-26.05	QP
	2	116.0391	25.62	-13.15	12.47	40.00	-27.53	QP
	3	483.2060	26.10	-5.29	20.81	47.00	-26.19	QP

Note: Emissions attenuated more than 20 dB below the permissible value are not reported.

The spectral diagrams are attached as below.


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Site: 2# Chamber

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Fax:+86-0755-26503396

Job No.: carry #208

Standard: EN55022 ClassB Radiated

Test item: Radiation Test

Temp.(C)/Hum.(%) 23 C / 48 %

EUT: HEADPHONE

Mode: Playing

Model: DJ-8805

Manufacturer: iLike

Polarization: Horizontal

Power Source: Powered by iPod

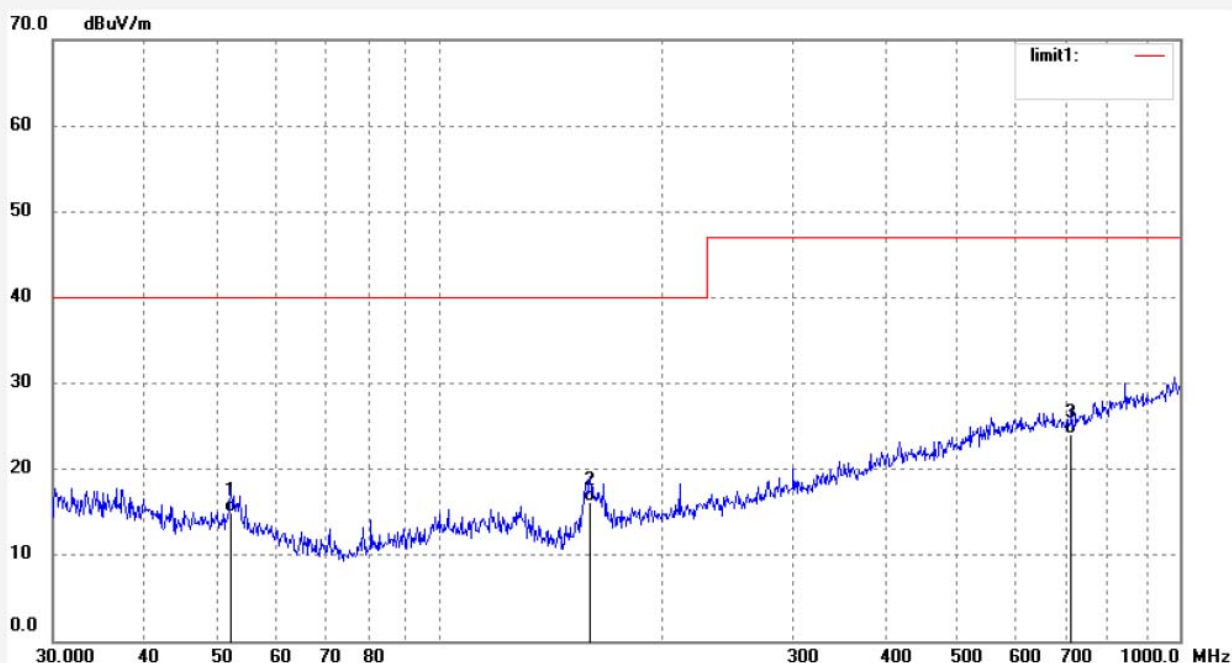
Date: 2014/06/12

Time: 3:49:46

Engineer Signature:

Distance:

Note: Report NO.:ATE20140982



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Degree (deg.)	Remark
1	52.2659	27.66	-12.76	14.90	40.00	-25.10	QP			
2	159.7586	30.78	-14.57	16.21	40.00	-23.79	QP			
3	713.6915	25.65	-1.56	24.09	47.00	-22.91	QP			



ACCURATE TECHNOLOGY CO., LTD.

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Science & Industry Park,Nanshan Shenzhen,P.R.China

Site: 2# Chamber

Tel:+86-0755-26503290

Fax:+86-0755-26503396

Job No.: carry #209

Standard: EN55022 ClassB Radiated

Test item: Radiation Test

Temp.(C)/Hum.(%) 23 C / 48 %

EUT: HEADPHONE

Mode: Playing

Model: DJ-8805

Manufacturer: iLike

Polarization: Vertical

Power Source: Powered by iPod

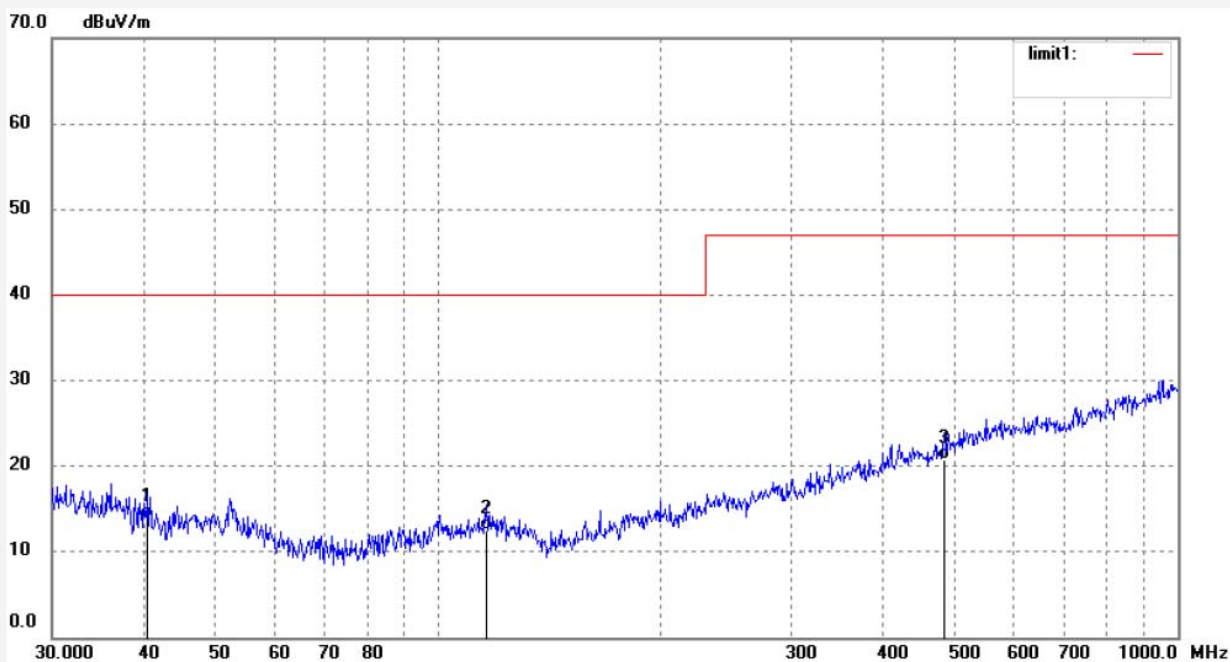
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Engineer Signature:

Distance:

Note: Report NO.:ATE20140982



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Height (cm)	Degree (deg.)	Remark
1	40.4411	25.59	-11.64	13.95	40.00	-26.05	QP			
2	116.0391	25.62	-13.15	12.47	40.00	-27.53	QP			
3	483.2060	26.10	-5.29	20.81	47.00	-26.19	QP			

5. ELECTROSTATIC DISCHARGE IMMUNITY TEST

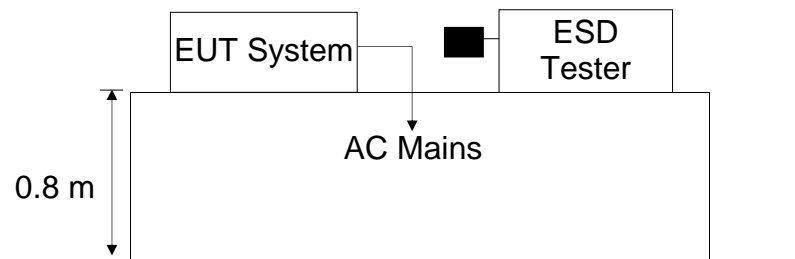
5.1. Block Diagram of Test Setup

5.1.1. Block diagram of connection between the EUT and simulators



(EUT: HEADPHONE)

5.1.2. Block diagram of ESD test setup



(EUT: HEADPHONE)

5.2. Test Standard

EN 55024: 2010

(IEC 61000-4-2: 2008 Severity Level: 3 / Air Discharge: $\pm 8\text{kV}$, Level: 2 / Contact Discharge: $\pm 4\text{kV}$)

Testing shall also be satisfied at the lower levels.

5.3. Severity Levels and Performance Criterion

5.3.1. Severity levels

Level	Test Voltage Contact Discharge (kV)	Test Voltage Air Discharge (kV)
1.	± 2	± 2
2.	± 4	± 4
3.	± 6	± 8
4.	± 8	± 15
X	Special	Special

5.3.2. Performance Criterion: **B**

5.4.EUT Configuration

The configuration of the EUT is same as Section 4.4.

5.5.Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 4.5 except for the test set up replaced by Section 5.1.

5.6.Test Procedure

5.6.1.Contact discharges to the conductive surfaces and to coupling planes:

The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points (a minimum of 50 discharges at each point). One of the test points shall be subjected to at least 50 indirect discharges (contact) to the centre of the front edge of the horizontal coupling plane. The remaining three test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, then at least 200 indirect discharges shall be applied in the indirect mode [see IEC 61000-4-2 for use of the Vertical Conducting Plane (VCP)]. Tests shall be performed at a maximum repetition rate of one discharge per second.

5.6.2.Air discharge at slots and apertures, and insulating surfaces:

On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur; examples are openings at edges of keys, or in the cover of keyboards and telephone handsets. Such points are tested using the air discharge method. See also IEC 61000-4-2 regarding painted surfaces. This investigation should be restricted to those areas normally handled by the user. A minimum of 10 single air discharges shall be applied to the selected test point for each such area.

The application of electrostatic discharges to the contacts of open connectors is not required by this publication.

5.7.Test Results

PASS

Please refer to the following page.

Electrostatic Discharge Test Results

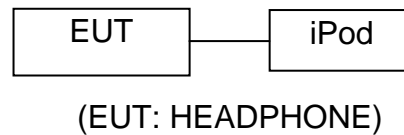
Accurate Technology Co., Ltd.

Applicant:	iLike Electronics Co., Ltd.	Test Date:	June 12, 2014
EUT:	HEADPHONE	Temperature:	25 °C
M/N:	DJ-8805	Humidity:	50%
Air discharge:	± 2kV; ± 4kV; ± 8kV	Criterion:	B
Contact discharge:	± 2kV; ± 4kV	Test Engineer:	LAN
Test Mode:	Playing		
Location		Kind A-Air Discharge C-Contact Discharge	Result
Nonconductive Enclosure		A	PASS
Conductive Enclosure		C	PASS
HCP		C	PASS
VCP of front		C	PASS
VCP of rear		C	PASS
VCP of left		C	PASS
VCP of right		C	PASS
Note:			
Test Equipment: ESD Simulator (HAEFELY, PESD1610)			

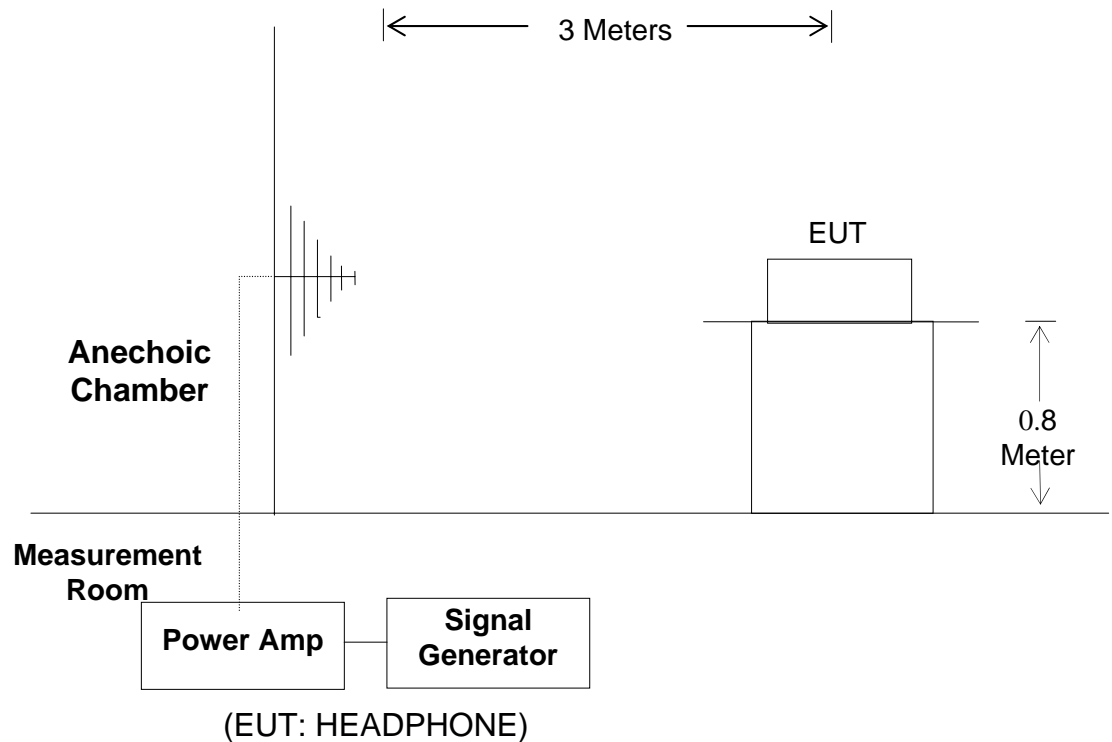
6. RF FIELD STRENGTH SUSCEPTIBILITY TEST

6.1. Block Diagram of Test

6.1.1. Block diagram of connection between the EUT and simulators



6.1.2. Block diagram of R/S test setup



6.2. Test Standard

EN 55024: 2010
(IEC 61000-4-3: 2010, Severity Level: 2, 3V/m)

6.3. Severity Levels and Performance Criterion

6.3.1. Severity Levels

Level	Field Strength V/m
1.	1
2.	3
3.	10
X	Special

6.3.2. Performance Criterion: **A**

6.4. EUT Configuration on Test

The configuration of the EUT is same as Section 4.4.

6.5. Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 4.5 except the test setup replaced as Section 6.1.

6.6. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarizations of the antenna are set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a CCD camera is used to monitor its screen.

All the scanning conditions are as following:

Condition of Test	Remark
1. Fielded Strength	3V/m (Severity Level 2)
2. Radiated Signal	Unmodulated
3. Scanning Frequency	80-1000MHz
4. Sweep time of radiated	0.0015 Decade/s
5. Dwell Time	1 Sec.

6.7. Test Results

PASS.

Please refer to the following page.

RF Field Strength Susceptibility Test Results

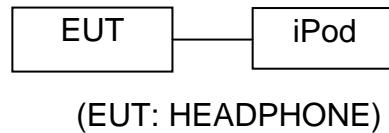
Accurate Technology Co., Ltd.

Applicant:	iLike Electronics Co., Ltd.		Test Date:	June 12, 2014		
EUT:	HEADPHONE		Temperature:	25°C		
M/N:	DJ-8805		Humidity:	50%		
Field Strength:	3 V/m		Criterion:	A		
Power Supply:	Powered by iPod		Frequency Range:	80 MHz to 1000MHz		
Test Mode:	Playing		Test Engineer:	LAN		
Modulation:	<input type="checkbox"/> None <input type="checkbox"/> Pulse <input checked="" type="checkbox"/> AM 1kHz		80%			
	Frequency Range 1:80 - 1000MHz		Frequency Range 2:			
Steps	#	/	%	#	/	%
	Horizontal		Vertical	Horizontal		Vertical
Front	PASS		PASS			
Right	PASS		PASS			
Rear	PASS		PASS			
Left	PASS		PASS			
Test Equipment : 1. Signal Generator : SMT03 (Rohde & Schwarz) 2. Power Amplifier : 250W1000A(AR) 3. Bilog Antenna : AT1080 (AR)						
Note:						

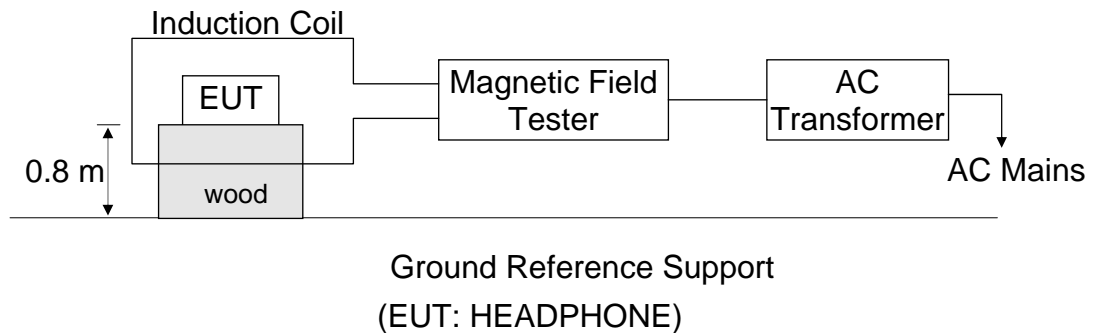
7. MAGNETIC FIELD SUSCEPTIBILITY TEST

7.1. Block Diagram of Test

7.1.1. Block diagram of connection between the EUT and simulators



7.1.2. Magnetic field test setup



7.2. Test Standard

EN 55024: 2010
(IEC 61000-4-8: 2009, Severity Level: Level 1, 1A/m)

7.3. Severity Levels and Performance Criterion

7.3.1. Severity Levels

Level	Field Strength A/m
1	1
2	3
3	10
4	30
5	100
X	Special

7.3.2. Performance Criterion: A

7.4.EUT Configuration on Test

The configuration of the EUT is same as Section 4.4.

7.5.Operating Condition of EUT

Same as conducted emission measurement, which is listed in Section 4.5 except the test setup replaced as Section 7.1.

7.6.Test Procedure

The EUT is placed in the middle of a induction coil (1*1m), under which is a 1*1*0.1m (high) table, this small table is also placed on a larger table, 0.8 m above the ground. Both horizontal and vertical polarizations of the induction coil are set on test, so that each side of the EUT is affected by the magnetic field. Also it can reach the same aim by change the position of the EUT.

7.7.Test Results

PASS.

Please refer to the following page.

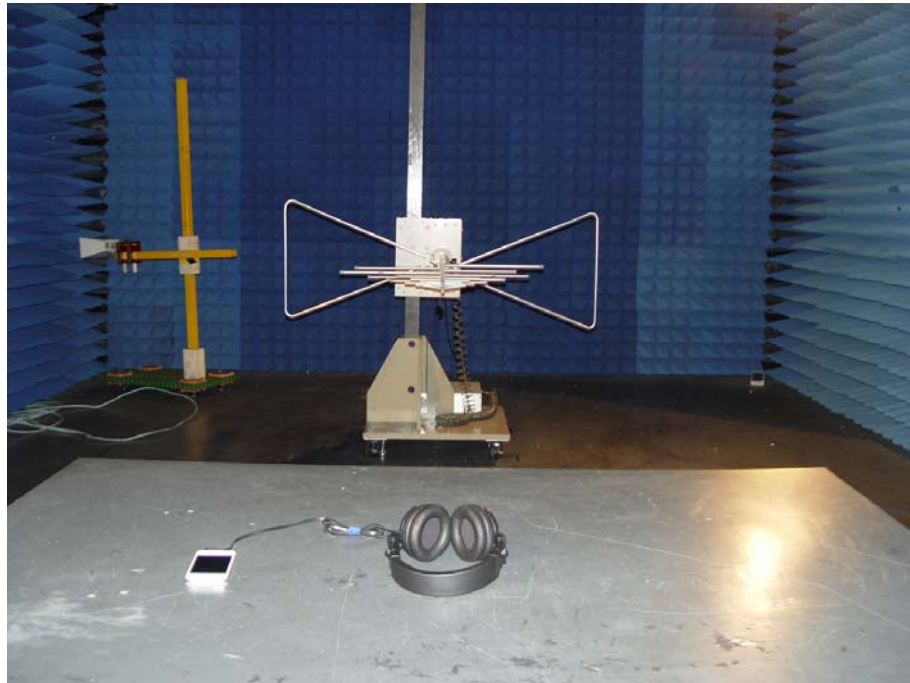
Magnetic Field Immunity Test Result

Accurate Technology Co., Ltd.

Applicant : iLike Electronics Co., Ltd. EUT : HEADPHONE M/N : DJ-8805			Test Date : June 12, 2014 Temperature : 25°C Humidity : 46%	
Test Mode : Playing			Test Engineer: Lan	
Test Level	Testing Duration	Coil Orientation	Criterion	Result
1A/m	5 mins	Horizontal	A	PASS
1A/m	5 mins	Vertical	A	PASS
Remark:			Test Equipment: Magnetic Field Tester: MAG100 AC Transformer: TDGC2J-5	

8. PHOTOGRAPHS

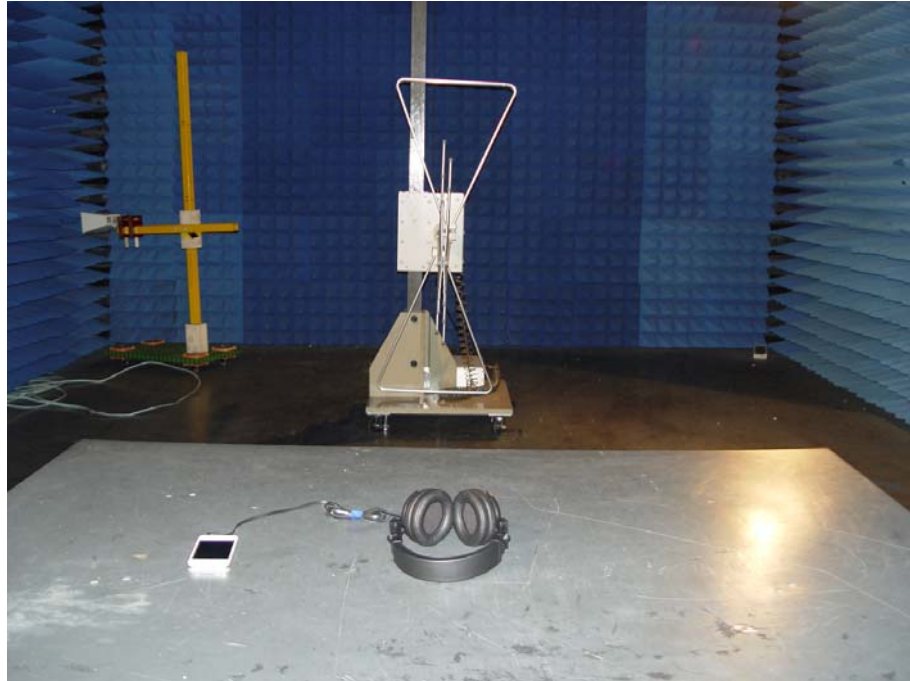
8.1.Photo of Radiated Emission Measurement



8.2.Photo of Electrostatic Discharge Test



8.3.Photo of RF Field Strength Susceptibility Test



8.4.Photo of Magnetic Field Susceptibility Test



8.5.Photo of EUT

